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	Application No.	Applicant(s)	jot
A	09/881,408	AHN ET AL.	
Notice of Allowability	Examiner	Art Unit	
	Thao X Le	2814	
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.			
1. This communication is responsive to <u>03/17/04</u> .			
2. The allowed claim(s) is/are <u>1-31,52 and 54-59</u> .			
3. \boxtimes The drawings filed on <u>13 June 2001</u> are accepted by the E	xaminer.		
4. ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) ☐ All b) ☐ Some* c) ☐ None of the: 1. ☐ Certified copies of the priority documents have been received. 2. ☐ Certified copies of the priority documents have been received in Application No 3. ☐ Copies of the certified copies of the priority documents have been received in this national stage application from the International Bureau (PCT Rule 17.2(a)). * Certified copies not received: Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application. THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. 5. ☐ A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient. 6. ☐ CORRECTED DRAWINGS (as "replacement sheets") must be submitted. (a) ☐ including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached 1) ☐ hereto or 2) ☐ to Paper No./Mail Date (b) ☐ including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d). 7. ☐ DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.			
Attachment(s) 1. Notice of References Cited (PTO-892) 2. Notice of Draftperson's Patent Drawing Review (PTO-948) 3. Information Disclosure Statements (PTO-1449 or PTO/SB/O Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. ☐ Interview Sur Paper No./M 08), 7. ☐ Examiner's A	lail Date mendment/Comment statement of Reasons for Alle	

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REASONS FOR ALLOWANCE

1. The following is an examiner's statement of reasons for allowance: Claims 1, 20, 52, 54, and 55 are allowed

- a. With respect to claims 1, 2, 6-31, 52, 54, and 55, the Applicant's reply on 02/19/04 in page 4 first paragraph has overcome the rejections of base claims 1, 20, 52 and 54. The prior art of record fails to discloses all the limitations of the base claim 1, 20, 52, 54, and 55 including the first metal-containing dielectric layer consisting of metal oxide having at least one element selected from Group IVB of the periodic table, and a second metal-containing dielectric layer consisting of metal oxide in contact with the first metal-containing dielectric layer and having at least one element selected from group IIIB of the periodic table.
- b. With respect to claim 3-5, the prior art of record fails to disclose all the limitation of the base claim 3 including heating the metal layer and layer of silicon dioxide to a temperature of from 200°C to less than 400°C and combing metal of the metal layer with oxygen of the silicon oxide to form a metal oxide dielectric material having at least one element selected from Group IVB of the periodic table, and a second metal-containing dielectric layer consisting of metal oxide in contact with the first metal-containing dielectric layer and having at least one element selected from group IIIB of the periodic table.
- c. With respect to claims 56-59, the prior art fails to disclose all the limitations of the base claims 56 and 59 including exposing the hafnium-containing layer and the

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lanthanum-containing layer to an oxygen comprising atmosphere by ion bombardment using an energy of about 10 ev or less.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

2. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Thao X Le whose telephone number is (571) 272-1708. The examiner can normally be reached on M-F from 8:00 AM - 4:30 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Wael M Fahmy can be reached on (571) 272 -1705. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Thao X. Le 12 Apr. 2004

> // LONG/PHAM PRIMARY EXAMINER